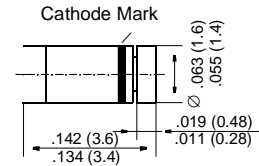


LL4148

FEATURES

- Silicon Epitaxial Planar Diode
- Fast switching diode
- Case Style: SOD-80
- Part #: LL4148

MiniMELE



MECHANICAL DATA

- Case: MiniMELF
- Weight: approx: 0.05gram

Dimensions in inches and (millimeters)

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

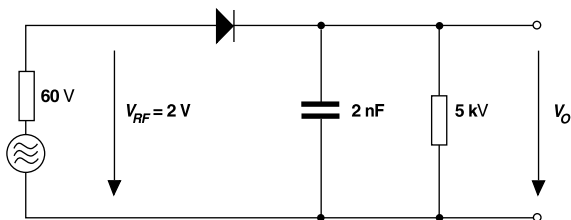
- Ratings at 25°C ambient temperature unless otherwise specified

	Symbol	Value	Unit
Reverse Voltage	V_R	75	V
Peak Reverse Voltage	V_{RM}	100	V
Forward DC current at $T_{amb} = 25\text{ }^\circ\text{C}$	I_F	200 ¹⁾	mA
Rectified Current (Average) Half Wave Rectification with Resist. Load at $T_{amb} = 25\text{ }^\circ\text{C}$ and $f \geq 50\text{ Hz}$	I_0	150 ¹⁾	mA
Surge Forward Current at $t < 1\text{ s}$ and $T_j = 25\text{ }^\circ\text{C}$	I_{FSM}	500	mA
Power Dissipation at $T_{amb} = 25\text{ }^\circ\text{C}$	P_{tot}	500 ¹⁾	mW
Junction Temperature	T_j	175	$^\circ\text{C}$
Storage Temperature Range	T_S	-65 to +175	$^\circ\text{C}$

¹⁾ Valid provided that electrodes are kept at ambient temperature.

Ratings at 25 °C ambient temperature unless otherwise specified

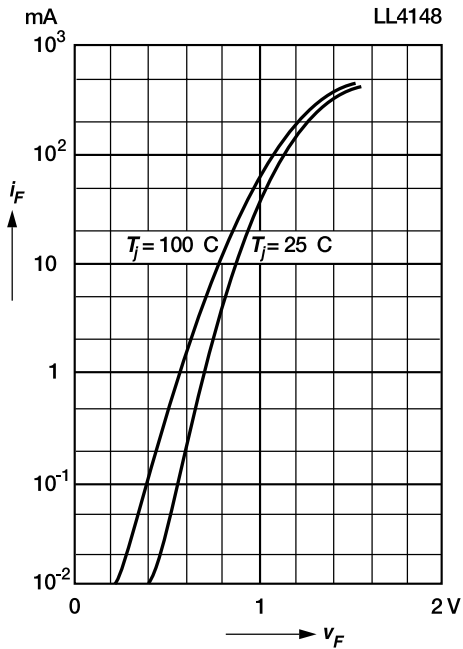
	Symbol	Min.	Typ.	Max.	Unit
Forward Voltage at $I_F = 10 \text{ mA}$	V_F	–	–	1	V
Leakage Current at $V_R = 20 \text{ V}$ at $V_R = 75 \text{ V}$ at $V_R = 20 \text{ V}, T_j = 150 \text{ °C}$	I_R I_R I_R	– – –	– – –	25 5 50	nA μA μA
Capacitance at $V_F = V_R = 0$	C_{tot}	–	–	4	pF
Voltage Rise when Switching ON tested with 50 mA Forward Pulses $t_p = 0.1 \text{ }\mu\text{s}$, Rise Time < 30 ns, $f_p = 5 \text{ to } 100 \text{ kHz}$	V_{fr}	–	–	2.5	V
Reverse Recovery Time from $I_F = 10 \text{ mA}$ to $I_R = 1 \text{ mA}$, $V_R = 6 \text{ V}$, $R_L = 100 \text{ }\Omega$	t_{rr}	–	–	4	ns
Thermal Resistance Junction to Ambient Air	R_{thJA}	–	–	0.35 ¹⁾	K/mW
Rectification Efficiency at $f = 100 \text{ MHz}$, $V_{\text{RF}} = 2 \text{ V}$	η_v	0.45	–	–	–
1) Valid provided that electrodes are kept at ambient temperature.					



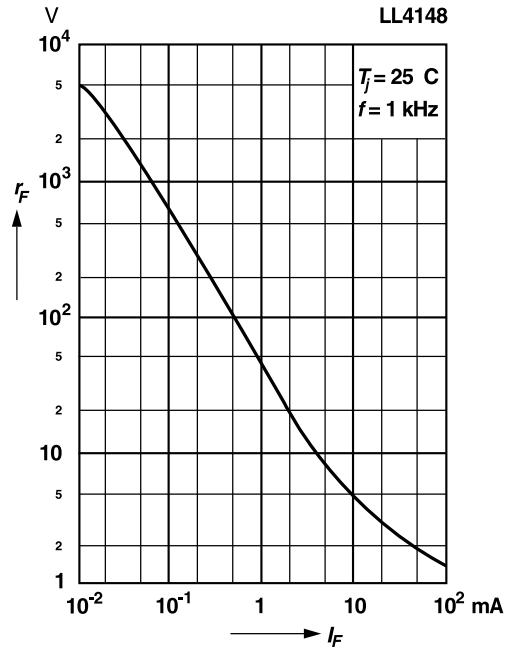
Rectification Efficiency Measurement Circuit

RATINGS AND CHARACTERISTIC CURVES LL4148

Forward characteristics

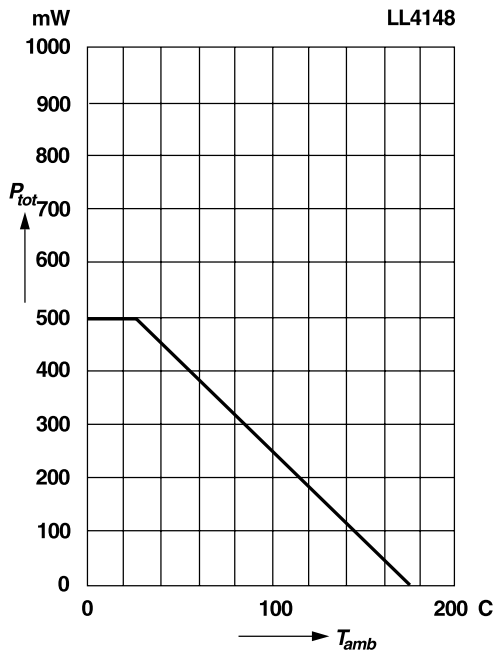


Dynamic forward resistance versus forward current

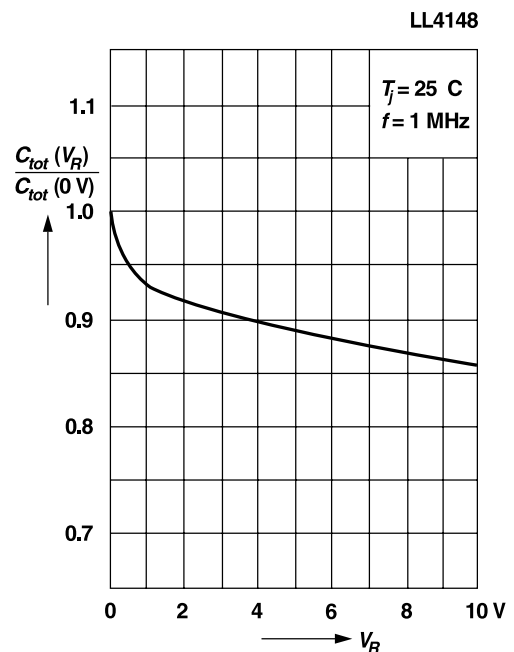


Admissible power dissipation versus ambient temperature

Valid provided that electrodes are kept at ambient temperature

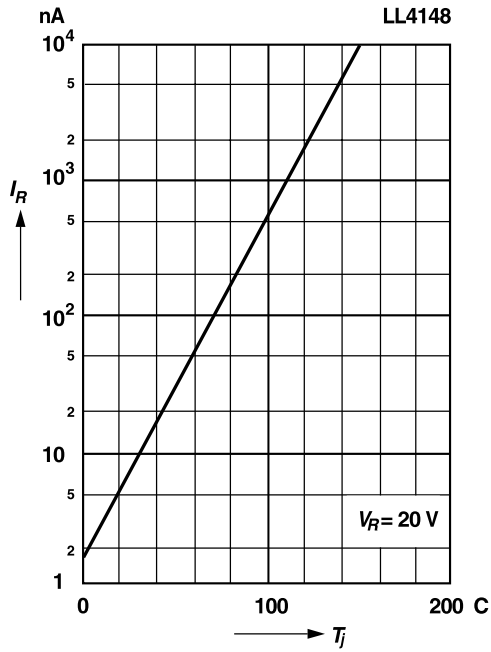


Relative capacitance versus reverse voltage



RATINGS AND CHARACTERISTIC CURVES LL4148

Leakage current
versus junction temperature



Admissible repetitive peak forward current versus pulse duration

Valid provided that electrodes are kept at ambient temperature

